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PATENT APPLICATION

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IN THE U.S. PATENT AND TRADEMARK OFFICE

March 22, 2006

Applicants: Hideki MISAWA et al

For : MAGNETIC MIGRATION AND REVERSAL DISPLAY PANEL AND
MAGNETIC MIGRATION AND REVERSAL DISPLAY METHOD

PCT International Application No.: PCT/JP2004/004625

PCT International Filing Date: March 31, 2004

U.S. Application No.

(if known, see 37 CFR 1.5): Unknown

Atty. Docket No.: 4700.P0325US

Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. These references constitute the art known to the Applicants and are believed to be distinguishable from the claimed invention or are explained on the enclosed search report. Accordingly, further comment at this point in time should not be necessary.

Respectfully submitted,

TFC/smd


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Reg. No. 37 512
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Encl: Copy of International Search Report
Form PTO-1449 and one copy of each listed reference

(00034791.DOC)

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /V.P./

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INFORMATION
DISCLOSURE
CITATION

Applicant: Hideki MISAWA et al

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U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
N.P./	AE	JP 62-53359	11-10-1987	MURATA	Abstract
N.P./	AF	JP 59-32796	08-10-1984	MURATA	Abstract
N.P./	AG	JP 51-146924	06-11-1975	OGATA	Abstract
N.P./	AH	JP 55-164815	12-22-1980	NOMURA	Abstract
N.P./	AI	JP 60-107689	06-13-1985	HOSAKA et al	Abstract
N.P./	AJ	WO 01/48548	07-05-2001	IKEDA et al	Abstract
N.P./	AK	JP 2002-82363	03-22-2002	OZAKI et al	Abstract

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AL	
	AM	
EXAMINER SIGNATURE		DATE CONSIDERED
/Vipin Patel/		05/08/2010

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.